

Skin effect

R.L. Chase, C. de La Taille, S. Rescia and N. Seguin, Nucl. Instr. and Meth. A 330 (1993) 228



- Skin effect:
 - Tendency of AC current to distribute itself within a conductor so that the current density near the surface of it is greater than at its core
 - $f \uparrow \rightarrow R \uparrow$
 - Define penetration or “skin” depth δ : $\delta = \sqrt{\frac{2\rho}{\omega\mu}}$
- Signal attenuation due to skin effect

- Resistance per unit length R_s :

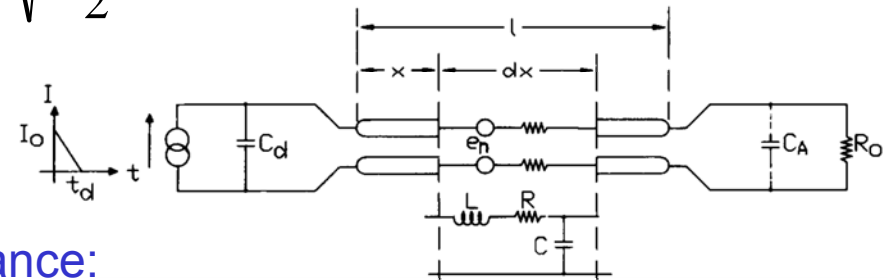
$$R_s = \frac{1}{W} \sqrt{\frac{\omega\mu\rho}{2}}$$

- It can be shown that:

$$Z_s = \frac{\sqrt{\mu\rho}}{W} \sqrt{j\omega}$$

- Transmission line characteristic impedance:

$$Z_0 = \sqrt{\frac{Z_s + j\omega L}{j\omega C}} \approx \sqrt{\frac{L}{C}}$$



Skin effect

- Signal attenuation due to skin effect (continued)

- Propagation constant:

$$\gamma = \sqrt{(Z_s + j\omega L)j\omega C} \approx \frac{\sqrt{\mu\rho}}{2Z_0W} \sqrt{j\omega} + \sqrt{LC} j\omega$$

- Transfer function of a length of line:

$$\frac{V(x+l, \omega)}{V(x, \omega)} = e^{-\gamma l} = e^{-\frac{\sqrt{\mu\rho}l}{2Z_0W} \sqrt{j\omega}} e^{-\sqrt{LC}lj\omega}$$

- Inverse Fourier transform:

$$h_1(t) = \frac{\tau_0}{2\sqrt{\pi}} t^{-\frac{3}{2}} e^{-\frac{\tau_0}{4t}} U(t) \quad \text{with} \quad \tau_0 = \frac{\sqrt{\mu\rho}l}{2Z_0W}$$

- And the step response of the transmission line:

$$u_1(t) = \text{erfc} \left[\frac{1}{2} \sqrt{\frac{\tau_0}{t}} \right]$$

Introduction of long time constants → strong attenuation

Skin effect: noise contribution

- Resistance per unit length R_s :
$$R_s = \frac{1}{W} \sqrt{\frac{\omega \mu \rho}{2}}$$
- Noise generator per unit length:
$$e_{n,l}^2(f) = 4KTR_s(f)$$

- Propagation constant (rearranged):
$$\gamma = \frac{R_s(\omega)}{2R_0} + j \frac{\omega}{v_p}$$

- Impedance seen at position x towards the detector:

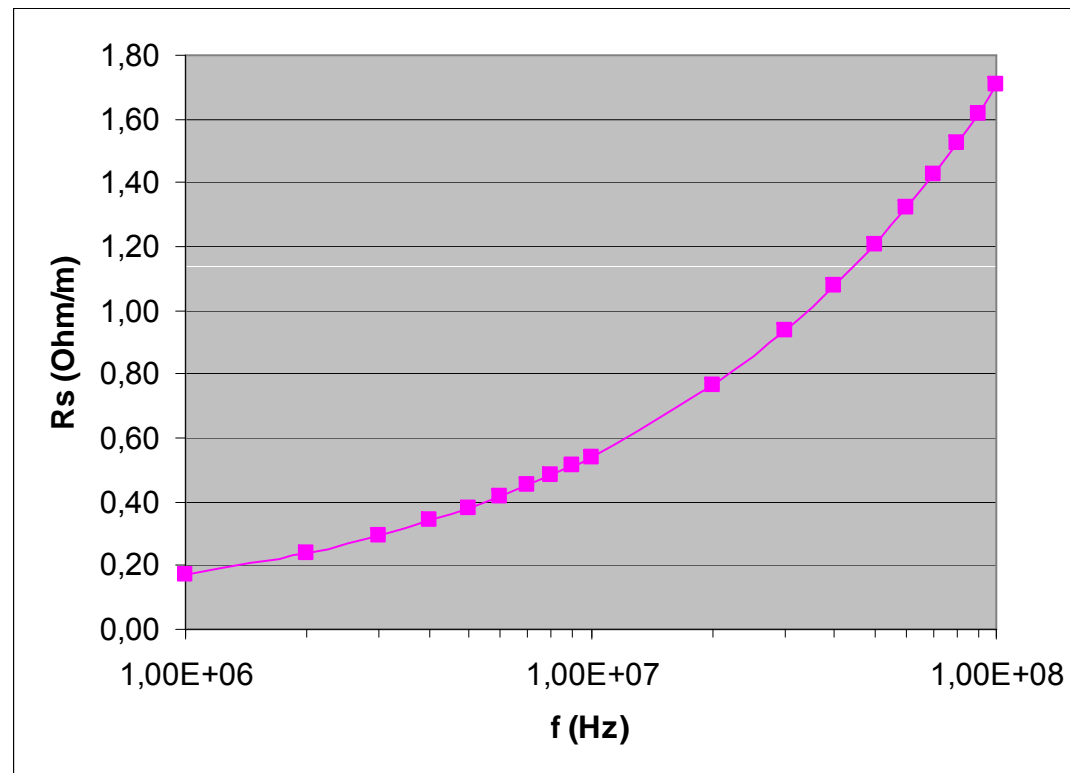
$$Z(x, \omega) = R_0 \frac{\frac{1}{j\omega C_d} + R_0 \operatorname{tgh}(\gamma x)}{R_0 + \frac{1}{j\omega C_d} \operatorname{tgh}(\gamma x)}$$

- The noise current per unit length through the terminating resistor R_0 :

$$i_{n,l}^2(x) = e_{n,l}^2 \frac{1}{|Z(x, \omega) + R_0|^2} |e^{-\gamma(l-x)}|^2 \longrightarrow i_n^2(\omega) = \int_0^l i_{n,l}^2(x) dx$$

Skin effect: noise contribution

- Rs values:

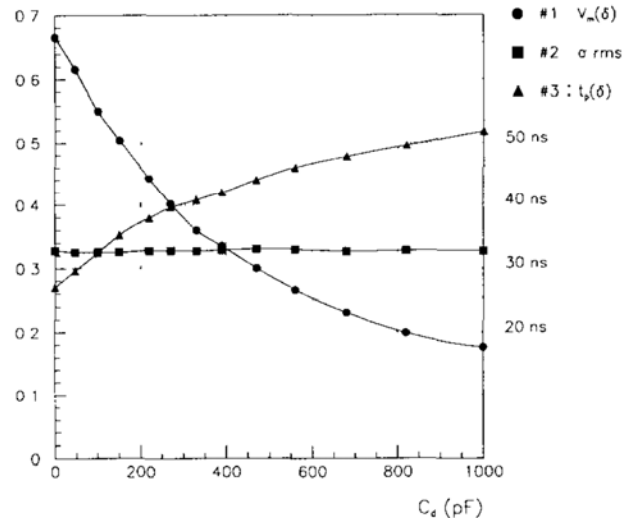


Skin effect noise measurements

R.L. Chase et Al./ Nucl. Instr. and Meth. A 343 (1994) 598

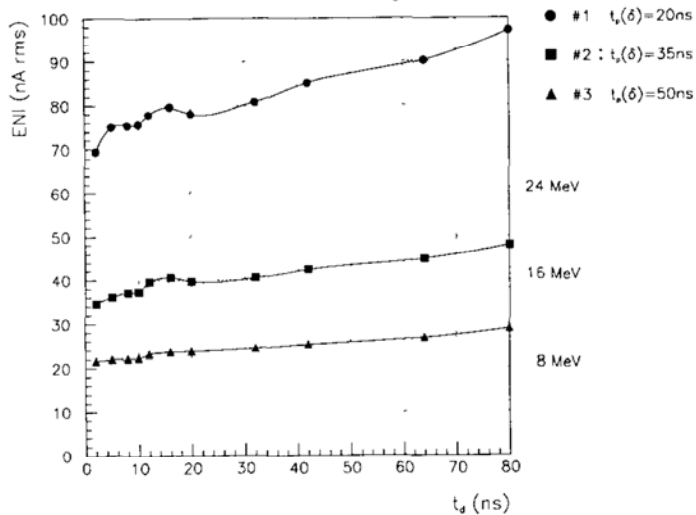


Signal and Noise vs detector capacitance



- Plots from noise measurements for ATLAS calorimeter (include amp+CRRC²)
- Signal and noise vs C_d
 - In ECAL case $C_d < 20$ pF
 - Observed correspondent $t_p \sim 10$ ns

OT ENI vs cable length



- ENI vs cable length:
 - Cable length = 60 ns (= 12 m)
 - $t_p \sim 10$ ns
 - Using ENI formula, extrapolate: ENI ~ 344 nA rms

$$ENI = e_n C_t \frac{B_S}{t_p^2} \oplus i_n \frac{B_S}{t_p^2}$$

Plans



- It seems not clear that the approximated results are correct
 - Review calculations
 - Calculate exact theoretical values for:
 - different C_d
 - cable lengths
 - t_p